

FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)  May 2, 2002			ATTY DOCKET NO. <b>00862.022511</b>		APPLICATION NO. <b>10/066,620</b>	
			APPLICANT <b>Atsushi TANAKA</b>			
			FILING DATE <b>February 6, 2002</b>		GROUP <b>2671-02673</b>	

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U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<div style="border: 1px solid black; border-radius: 50%; padding: 10px; display: inline-block;">             OIP              VS              MAY 02 2002              PATENT &amp; TRADEMARK OFFICE           </div>	4,613,964	09/23/1986	Ichikawa, et al.	369	45		
	4,886,943	12/12/1989	Suzuki, et al.	178	18		
	4,887,245	12/12/1989	Mori, et al.	367	129		
	4,897,510	01/30/1990	Tanaka, et al.	178	18		
	4,910,363	03/20/1990	Kobayashi, et al.	178	18		
	4,931,965	06/05/1990	Kaneko, et al.	364	560		
	4,980,518	12/25/1990	Kobayashi, et al.	178	18		
	5,017,913	05/21/1991	Kaneko, et al.	340	712		
	5,070,325	12/03/1991	Tanaka, et al.	340	706		
	5,097,102	03/17/1992	Yoshimura, et al.	178	18		
VS	5,142,106	08/25/1992	Yoshimura, et al.	178	18		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)		

EXAMINER <div style="font-size: 1.5em; font-family: cursive;">V. Shantlan</div>	DATE CONSIDERED <div style="font-size: 1.5em; font-family: cursive;">11/24/03</div>
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.  
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Sheet 1 of 3

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
**00862.022511**APPLICATION NO.  
**10/066,620**APPLICANT  
**Atsushi TANAKA**LIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

May 2, 2002

FILING DATE  
**February 6, 2002**GROUP  
**2671**

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>VS</i>	5,210,785	05/11/1993	Sato, et al.	379	58	
<i>VS</i>	5,231,394	07/27/1993	Sato	341	50	
<i>VS</i>	5,239,138	08/24/1993	Kobayashi, et al.	178	18	
<i>VS</i>	5,500,492	03/19/1996	Kobayashi, et al.	178	18	
<i>VS</i>	5,517,553	05/14/1996	Sato	379	59	
<i>VS</i>	5,539,678	07/23/1996	Tanaka, et al.	364	561	
<i>VS</i>	5,565,893	10/15/1996	Sato, et al.	345	177	
<i>VS</i>	5,621,300	04/15/1997	Sato, et al.	320	5	
<i>VS</i>	5,714,698	02/03/1998	Tokioka, et al.	73	865.4	
<i>VS</i>	5,736,979	04/07/1998	Kobayashi, et al.	345	177	
<i>VS</i>	5,751,133	05/12/1998	Sato, et al.	320	13	
<i>VS</i>	5,805,147	09/08/1998	Tokioka, et al.	345	173	
<i>VS</i>	5,818,429	10/06/1998	Tanaka, et al.	345	173	
<i>VS</i>	5,831,603	11/03/1998	Yoshimura, et al.	345	177	

## FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

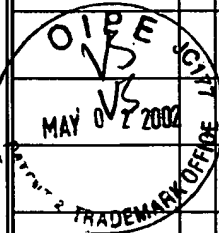

EXAMINER

DATE CONSIDERED

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U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	5,933,149	08/03/1999	Mori, et al.	345	442	
	5,936,207	08/10/1999	Kobayashi, et al.	178	18.01	
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